## Notice of References Cited Application/Control No. 10/772,318 Examiner Chen-Wen Jiang Applicant(s)/Patent Under Reexamination BASH ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-5,718,628 A	02-1998	Nakazato et al.	454/184
*	В	US-6,283,380 B1	09-2001	Nakanishi et al.	236/49.3
*	С	US-6,639,794 B2	10-2003	Olarig et al.	361/687
*	D	US-2002/0173877 A1	11-2002	Zweig, Stephen Eliot	700/245
*	Ε	US-2004/0139110 A1	07-2004	LaMarca et al.	707/104.1
*	F	US-2005/0038562 A1	02-2005	Bash et al.	700/245
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
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	X	

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